Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	er
10/600,852	TEH, JIN TEIK	
Examiner	Art Unit	
Chirag R. Patel	2141	

	SEARCHED						
Class	Subclass	Date	Examiner				
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

(INCLUDING SEARCH STRATEGY)					
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